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The gas proportional scintillation counter/microstrip gas chamber hybrid detector with argon filling

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Abstract

We present the results of a study of an argon gas proportional scintillation counter instrumented with a CsI-coated microstrip plate placed in the argon envelope. Although the measured light amplification gain and the photoelectron collection efficiency are 70% and 30–40% higher than those obtained in a similar xenon detector, the charge gain achieved in argon for the avalanches produced by the photoelectrons at the microstrip anodes is a factor of ten lower than in xenon. In both cases, these gains are limited by optical positive feedback. The energy resolution achieved for 5.9 keV X-rays was 14.8% compared to 12% in xenon. © 2002 Elsevier Science B.V. All rights reserved.

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Keywords: Argon; Gas scintillation counters; MSGC; CsI photocathodes; X-rays

1. Introduction

The gas proportional scintillation counter/microstrip gas chamber (GPSC/MSGC) hybrid detector has been developed recently [1]. A CsIcoated microstrip plate (MSP) is directly placed within the scintillation gas envelope as the photosensor substituting the commonly used photomultiplier tube (PMT) in GPSCs. This hybrid detector presents an attractive alternative to PMT-instrumented GPSCs in applications where large detection area, compactness, low-power consumption, and low cost are important. The volume resistivity of the CsI coating is 10^{10} – $10^{11} \Omega$ cm [2] and its presence does not compromise the charge multiplication capacity of the MSP. This value is comparable to the semi-conducting glass substrates used for high-rate MSPs applications [3,4]. Consequently, we expect the presence of the CsI coating to reduce charge build-up on the MSP.

A xenon-filled hybrid detector was studied and a 12% energy resolution was obtained for 5.9 keV X-rays [1]. Although this resolution is not as good as that achieved with PMT-based GPSCs (8% for 6-keV X-rays) it is better than that of other xenon detectors based on charge amplification.

One of the factors limiting the performance of a xenon hybrid detector is the reduced number of photoelectrons that are transmitted to the

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avalanche region around the anode strips. This is due to backscattering of the photoelectrons in the xenon atoms. Other lower Z-filling gases, such as argon, which present more favourable photoelectron collection efficiency [5,6] (the ratio of the photoelectrons that escape from the photocathode to the number emitted) would improve the performance of the hybrid detector. While the photoelectron collection efficiency is much lower in xenon than in vacuum (being 20%, 30% and 50% at reduced electric fields above the cathode surface of 7, 20 and $36 \,\mathrm{V \, cm^{-1} \, Torr^{-1}}$, respectively, [6]), it reaches values higher than 90% at electric fields above $6 \,\mathrm{V \, cm^{-1} \, Torr^{-1}}$ [7,8] for photocathodes in argon. This may result in increased signal enhancement and improved detector energy resolution.

The quantum efficiency of CsI is about a factor of two higher for argon scintillation ($\sim 55\%$ at 130 nm [9]), than for xenon scintillation ($\sim 30\%$ at 170 nm [9]). However, the number of VUV photons produced per primary electron per centimetre per Torr in argon is only about 35% of those produced in xenon, for reduced electric fields corresponding to optimum operation conditions [10].

In the present work, the performance of an argon-filled GPSC/MSGC hybrid detector is investigated. Light amplification gain (i.e. the number of detected photoelectrons per primary electron), photoelectron collection efficiency, and energy resolution are determined and compared with a xenon-filled hybrid detector.

2. Description

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The GPSC/MSGC hybrid detector is depicted schematically in Fig. 1. It features a 4-cm deep absorption/drift region and a 1-cm deep scintillation region separated by a mesh grid, G1. It is filled with pure argon at 800 Torr $(1.07 \times 10^5 \text{ Pa})$.

The radiation window and the focusing electrode F are maintained at negative high voltage, $-HV_0$, while the G1-grid (80 µm diameter stainless steel wire with 900 µm spacing) and its holder electrode are kept at $-HV_1$. The MSP is a CERN model MS-4. It consists of 10 µm anodes and

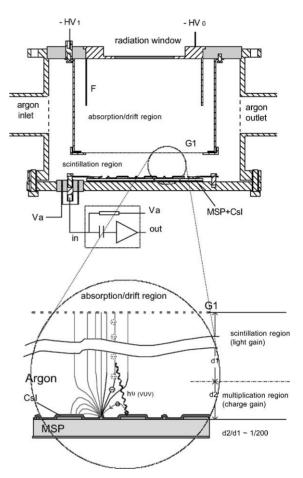


Fig. 1. Schematic of the GPSC/MSGC hybrid detector.

80 µm cathodes with a 200 µm pitch, fabricated of 0.2 µm thick chromium film deposited on a 500 µm Desag D263 glass substrate. The backplane is a flat, unstructured layer of 0.1 µm chromium. The backplane and cathodes are maintained at ground potential while a positive voltage V_a is applied to all the anodes. The electric field in the drift region is determined by the voltage difference between G1 and the radiation window while the G1 voltage determines the electric field in the scintillation region. The electric field above the cathode strips is determined by both the anode strips voltage and by the G1 voltage. The anode strips voltage determines the MSP gain.

A 500 nm thick and 30 mm in diameter layer of high-purity CsI was vacuum deposited onto the

surface of the MSP. Special care was taken to avoid water contamination of the CsI film: the MSP was heated at temperatures of about 100°C during 1 h before CsI evaporation, the maximum exposing time of the CsI film to air was less than 10 min, and the CsI film was heated under vacuum at about 80°C for 24 h after the CsI-covered MSP had been placed inside the detector [11–13].

Primary electron clouds from X-ray interactions in the absorption region drift towards the scintillation region under the influence of a weak electric field (below the argon scintillation threshold, $\sim 0.7 \,\mathrm{V \, cm^{-1} \, Torr^{-1}}$ [14]). The electric field in the scintillation region is high enough for each primary electron to gain enough energy between collisions to excite the argon atoms, producing VUV scintillation light as a result of the gas deexcitation processes. The scintillation light intensity is proportional to the number of primary electrons and, thus, to the X-ray energy. The VUV scintillation photons incident on the CsI-film deposited on the MSP surface induce the emission of photoelectrons from the active areas, the cathode strips. The photoelectrons undergo charge avalanche multiplication in the intense electric field around the MSP anodes.

The CsI-coated MSP serves simultaneously as the GPSC collection grid for the primary electron cloud, the photosensor for the GPSC VUV scintillation, and the amplification stage for the photoelectrons. While the upper region, d_1 , functions as the uniform-field scintillation region of a conventional GPSC, the region d_2 (<50 µm) functions as a standard MSGC. This hybrid system functions as a GPSC rather than a MSGC [1].

3. Experimental results and discussion

Fig. 2 presents a typical pulse-height distribution obtained with the argon hybrid detector for a 2 mm collimated 5.9-keV X-ray beam from a ⁵⁵Fe radioactive source, with the K_β-line absorbed by a chromium film. Reduced electric fields of 0.3 and $5.25 \text{ V cm}^{-1} \text{ Torr}^{-1}$ were used in the drift and scintillation region, respectively, and 220 V were applied to the MSP anode strips, corresponding to reduced electric fields ranging from 8 to

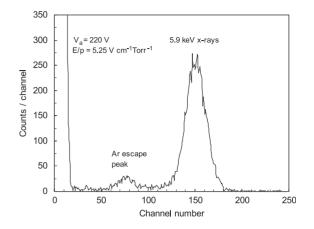


Fig. 2. Typical pulse-height distribution for 5.9 keV X-rays obtained with the argon GPSC/MSGC hybrid detector for $V_a = 220 \text{ V}$, E/p = 0.3 and 5.25 V cm⁻¹ Torr⁻¹ in the absorption and scintillation region, respectively.

 $30 \text{ V cm}^{-1} \text{ Torr}^{-1}$ above the MSP cathode strips. The spectral features include the 5.9-keV peak, the argon K-fluorescence escape peaks, and the electronic noise tail in the low-energy limit.

Anode pulses were pre-amplified with a CAN-BERRA 2006 charge-to-voltage preamplifier (sensitivity of 235 mV per 10^6 ion pairs) and linearly amplified with a TENNELEC TC243 amplifier (8-µs peaking time constants). For peak amplitude and energy-resolution measurements, pulse-height distributions were fitted to a Gaussian superimposed on a linear background.

3.1. Detector operational characteristics

Fig. 3 depicts the argon detector relative pulse amplitude and energy resolution as a function of the reduced electric field E/p (the electric field intensity divided by the gas pressure p) in the scintillation region for 5.9- and 22.1-keV X-rays, while keeping the reduced electric field constant in the drift region (~0.3 V cm⁻¹ Torr⁻¹) as well as the photosensor gain ($V_a = 220$ V). The experimental results reveal the approximately linear trend characteristic of the GPSC secondary scintillation yield (the solid line superimposed on the experimental data). Below the scintillation threshold pulse amplitudes become constant, being

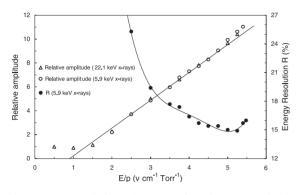


Fig. 3. Detector relative pulse amplitude and energy resolution as a function of the reduced electric field in the scintillation region for 5.9 and 22.1 keV X-rays and for a constant photosensor gain ($V_a = 220$ V) and reduced electric field in the drift region (~0.3 V cm⁻¹ Torr⁻¹).

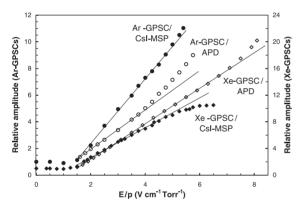


Fig. 4. Detector relative pulse amplitude as a function of the reduced electric field in the scintillation region for argon- and xenon-filled GPSCs instrumented with an avalanche photodiode (APD) or a CsI-MSP photosensor, maintaining constant the photosensor gains and the reduced electric fields in the drift region.

the pulse height due to the amplification of primary electrons only.

For comparison purposes, in Fig. 4 we depict the relative pulse amplitude as a function of E/p in the scintillation region for argon- and xenon-filled GPSCs instrumented with an avalanche photodiode (APD) or a CsI-MSP photosensor, maintaining constant the photosensor gains and the reduced electric fields in the drift region. Different behaviours are observed for argon and xenon hybrid detectors at high E/p values in the

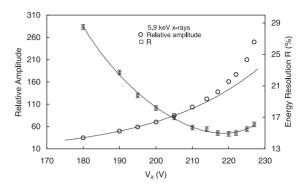


Fig. 5. Detector relative pulse amplitude and energy resolution as a function of the anode-to-cathode strips voltage, V_a , for 5.9 keV X-rays and for constant reduced electric fields in the drift and scintillation region (E/p = 0.3 and $5.25 \,\mathrm{V \, cm^{-1} \, Torr^{-1}}$, respectively).

scintillation region when compared to the APD instrumented GPSCs: while for xenon the detector pulse amplitude tends to saturate; for argon, the detector pulse amplitude still increases with E/p, though not as much as it would if only the charge multiplication occurring in the scintillation region above the argon ionisation threshold $(\sim 3.7 \,\mathrm{V \, cm^{-1} \, Torr^{-1}})$ were taken into account (as in the GPSC-APD detectors [14,15]). These differences are due to the decrease of the electric field intensity at the CsI photocathode surface with increasing electric field in the scintillation region [1,16]. The experimental results show that the influence of the electric field intensity at the CsI surface on the photoelectron collection efficiency becomes significant at much lower electric fields in argon than in xenon and that this influence, though smaller, is still noticeable in the argon detector for the operating conditions described in this work.

In Fig. 5 we depict the argon detector relative pulse amplitude and energy resolution as a function of the anode voltage, V_a , for 5.9-keV X-rays, while maintaining constant the E/p in the drift and in the scintillation region (0.3 and $5.25 \text{ V cm}^{-1} \text{ Torr}^{-1}$, respectively). An exponential function (solid line) is superimposed on the experimental results for comparison. The photosensor gain depicts the characteristic exponential variation of charge avalanche processes in MSGCs

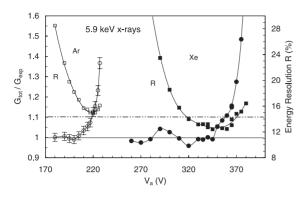


Fig. 6. Positive feedback gain as a function of the anode-tocathode strips voltage, V_a , for the Argon and Xenon hybrid detectors and for 5.9 keV X-rays.

up to V_a voltages of about 205 V. Above this value the gain diverges from its initial behaviour due to optical positive feedback as a result of additional scintillation produced in the electron avalanche process, leading to a faster increase of gain, an effect also observed in the xenon detector [1]. Fig. 6 presents the relative gain due to positive feedback, G_{tot}/G_{exp} , where G_{tot} is the measured total gain of the detector and G_{exp} is the gain represented by the exponential function (Fig. 5), together with the results obtained with xenonfilling [1]. For both argon and xenon gases, the detector energy resolution degrades above positive feedback gains of about 1.1, achieved at V_a voltages of 220 and 360 V, respectively.

As expected [1,17], the best detector energy resolution is achieved for reduced electric fields in the scintillation region somewhat above the argon ionisation threshold (Figs. 3 and 4). The energy resolution of a GPSC operating in a low charge-multiplication regime, in the scintillation region, is given by [1,17].

$$R = 2.355 \sqrt{\frac{(F+f)}{N} + \frac{1}{N_{\rm e}} \left(1 + \left(\frac{\sigma_q}{G_q}\right)^2\right)}$$
$$= 2.355 \sqrt{\frac{(F+f)}{N} + \frac{(1+f')}{N_{\rm e}}}$$
(1)

where N is the average number of primary electrons produced per incident X-ray photon, F

is the relative variance of N, the Fano factor, $f = (\sigma_G/G)^2$ is a measure of the fluctuations in the electron multiplication gain in the scintillation region, N_e is the average number of photoelectrons produced in the photosensor per incident X-ray photon and $f' = (\sigma_q/G_q)^2$ is a measure of the fluctuations in the electron multiplication gain of the photosensor. In a low multiplication regime f is much smaller than F. As the reduced electric field in the scintillation region increases, N_e increases in spite of the decreasing photoelectron extraction efficiency (Fig. 4), and the small increase in the first term of Eq. (1) is compensated by a decrease in the second term, until the degrading effect of the increase of f dominates.

An energy resolution of 14.8% for 5.9-keV X-rays was achieved for $E/p = 5.25 \text{ V cm}^{-1} \text{ Torr}^{-1}$ and $V_a = 220 \text{ V}$. Although a better result than GEM-based gas detectors [18], this resolution is worse than argon proportional counters [19], microstrip gas chambers [20], or gas proportional scintillation counters instrumented with VUV-sensitive avalanche photodiodes [14]. The electronic noise tail in the low-energy limit is 700 eV, a factor of three higher than the xenon hybrid detector, but similar to the argon-GPSC instrumented with a VUV-sensitive avalanche photodiode [14].

3.2. Light amplification gain and photoelectron collection efficiency

From the experimental results presented in Fig. 3 we can estimate the detector light amplification gain L (i.e., the number of detected photoelectrons per primary electron, $L = N_{\rm phe}/N_{\rm pre}$) provided the average gain of photoelectron avalanches, $G_{\rm phe}$, relative to the average gain of primary electron avalanches, $G_{\rm pre}$, is known. For the GPSC-MSGC hybrid detectors, we obtain

$$G_{\rm phe} \times N_{\rm phe} + G_{\rm pre} \times N_{\rm pre} = A_r \times G_{\rm pre} \times N_{\rm pre}$$
 (2)

where A_r is the amplitude achieved at a given E/p relative to that achieved at E/p = 0 V cm⁻¹ Torr⁻¹.

 $G_{\rm phe}$ and $G_{\rm pre}$ have been calculated by numerical simulation [16] using Townsend coefficients [21] for both argon and xenon gases at 800 Torr,

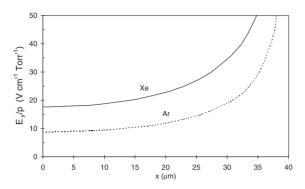


Fig. 7. Calculated reduced electric field perpendicular to the CsI surface, E_y/p , as a function of the position along the cathode width, *x*, assuming x = 0 is the cathode centre, and for $E/p = 5 \text{ V cm}^{-1} \text{ Torr}^{-1}$ in the scintillation region, $V_a = 220 \text{ V}$ (Ar curve) and 360 V (Xe curve).

 $E/p = 5 \text{ V cm}^{-1} \text{ Torr}^{-1}$, $V_a = 220 \text{ V}$ (for argon) and 360 V (for xenon), and assuming a photoelectron emission uniformly distributed over the photocathode active area. From the simulation results we obtained $G_{\text{phe}}/G_{\text{pre}} = 1.2$ and 1.8 for argon and xenon, respectively, and $G_{\text{phe}}(\text{Xe}) \sim 10 \times G_{\text{phe}}(\text{Ar})$. From the experimental results presented in Fig. 4 for both argon and xenon hybrid detectors we obtain $A_r = 10$ and 9, respectively, which lead to L = 7.7 and 4.5 for the specified conditions. The light amplification gain in argon is 70% higher than in xenon. The higher photoelectron transmission from the cathode to the anode strips in argon relative to xenon is one factor responsible for this increase.

In Fig. 7 we depict the reduced electric field intensity perpendicular to the CsI surface, E_y/p , as a function of the position along the cathode width, x, assuming x = 0 is the cathode centre. Calculations were made for $E/p = 5 \text{ V cm}^{-1} \text{ Torr}^{-1}$ in the scintillation region, for $V_a = 220 \text{ V}$ (Ar curve) and 360 V (Xe curve), using a 2D electric field simulation code [22]. Fig. 7 shows that the reduced electric field at the CsI surface for the argon operating conditions is a factor of two lower than that for xenon, with values around 10-25 V cm⁻¹ Torr⁻¹ for almost all cathode strip areas.

The average photoelectron collection efficiency, $C_{\rm e}$, of the GPSC/MSGC can be estimated by

$$C_{\rm e} = L/N_{\rm uv} \times QE^{-1} \tag{3}$$

where $N_{\rm uv}$ is the number of VUV photons, per primary electron, impinging the active area of the photocathode and QE is its quantum efficiency. The total number of VUV photons produced per primary electron upon crossing the scintillation region is given by

$$N_{\rm tuv} = Q_{\rm sc} \times \varepsilon_{\rm sc} / \varepsilon \tag{4}$$

where $Q_{\rm sc}$ is the scintillation efficiency (i.e., the fraction of energy the primary electron gains from the electric field that is converted into scintillation), $\varepsilon_{\rm sc}$ is the total energy available from the electric field and ε is the average scintillation photon energy. The number of UV photons striking the photocathode active area is then

$$N_{\rm uv} = N_{\rm tuv} \times f_{\Omega} \times f_{\rm c} \tag{5}$$

where f_{Ω} is the fraction of the average solid angle subtended by the CsI-film relative to the primary electron trajectory and f_c is the fraction of the active photocathode area, i.e., the fraction of the area occupied by the cathode strips. For our [23], $f_{\rm c} = 0.4$ [1] and detector, $f_{0} \sim 0.3$ $\varepsilon_{VG1} = 4 \text{ keV}$ for an $E/p = 5 \text{ V cm}^{-1} \text{ Torr}^{-1}$ in the scintillation region. $\varepsilon = 9.8 \text{ eV}$ for argon and 7.2 eV for xenon [24], while $Q_{sc} = 0.72$ and 0.78 for argon [10] and xenon [25], respectively. Substituting these values in Eqs. (4) and (5), we obtain $N_{\rm uv} \sim 35$ and 52 for the argon and xenon detectors, respectively. Assuming a quantum efficiency of 55% and 30% for the CsI photocathode at 130 and 170 nm [9], the photoelectron collection efficiency is obtained by Eq. (3), leading to values of about 40% and 30% for argon and xenon detectors, respectively.

The photoelectron collection efficiency estimated for the xenon detector is lower than that calculated by a detailed Monte Carlo simulation [6] for the reduced electric fields between 17 and $40 \text{ V cm}^{-1} \text{ Torr}^{-1}$ (~30–55%). If we assume an average photoelectron collection efficiency between 40% and 45%, we will obtain a value between ~20% and 22% for the quantum efficiency of our photocathode at 170 nm, which is an acceptable value for a vacuum-heated CsI photocathode.

However, the estimated photoelectron collection efficiency for argon is much lower than that

obtained in Ref. [7] ($\sim 90\%$). Assuming a photoelectron collection efficiency of 90% for argon we would arrive at a $OE \sim 25\%$ for our photocathode at 130 nm which we believe it is too low a value for the QE of our CsI photocathode, taking into account the estimated values for its QE at 170 nm. On the other hand, if we assume a value of $\sim 35\%$ for the QE at 130 nm for our photocathode (based on a QE of 20% at 170 nm), it will lead to an estimated value of $\sim 60\%$ for the photoelectron collection efficiency in the argon detector, which is still low compared to that of Ref. [7]. Additionally, our experimental results show that there is still some influence of the electric field intensity at the CsI surface on the photoelectron collection efficiency even for electric fields above $10 \,\mathrm{V \, cm^{-1} \, Torr^{-1}}$, which is consistent with photoelectron collection efficiencies lower than that of Ref. [7].

A possible reason for this difference may be related with the different energy distributions of the photoelectrons emitted by the CsI for 185 (used in Refs. [7,8]) and 130 nm (the argon scintillation) irradiations [26,27]. While the 185 nm irradiation of the CsI leads to the emission of photoelectrons with few tens of eV [7,8,26,27], in the range of the argon Ramsauer minimum, the 130 nm irradiation leads to the emission of photoelectrons with energies of few eV, a region where the argon total scattering cross-section is one order of magnitude higher and has a quite different behaviour.

4. Conclusions

The performance of an argon-filled GPSC/ MSGC hybrid detector has been described. An energy resolution of 14.8% for 5.9-keV X-rays has been achieved for a reduced electric field of $5.25 \text{ V cm}^{-1} \text{ Torr}^{-1}$ in the scintillation region and for an anode-to-cathode voltage of 220 V in the MSP. Although better than that obtained with GEM-based gas detectors, this energy resolution is worse than that obtained with argon-based proportional counters, microstrip gas chambers, or gas proportional scintillation counters instrumented with VUV-sensitive avalanche photodiodes, and that achieved with a xenon hybrid detector. However, the number of detected photoelectrons per primary electron is 70% higher and the effective collection efficiency of photoelectrons emitted by the photocathode is 30–40% higher than when the CsI-coated microstrip plate is operated in xenon. The reduced charge gain achieved in the MSP (one tenth of that for xenon) prior to the onset of optical positive feedback is one factor responsible for the poorer performance achieved with the argon hybrid detector.

In these detectors, the VUV photon impact and rare gas ion impact on the CsI are the main factors responsible for its ageing [9,28]. These cause the evaporation of iodine and the consequent metallization of the CsI film, leading to an enhancement of the electron affinity of the photocathode surface and, thus, to a reduction on the photocathode QE. The combined influence of both factors on the CsI film ageing was studied [1] by irradiating it with a constant flux of $\sim 10^8$ Xe-VUV photons s⁻¹ cm⁻² maximum usable CsI-MSP gain at the $(V_{\rm a} = 360 \,\mathrm{V})$. After an initial reduction of about 15% in the relative quantum efficiency with the surface charge density delivered by the CsI up to about 4μ Cmm⁻², only a small variation occurs when the delivered charge increases up to $15 \,\mu\text{C}\,\text{mm}^{-2}$ (<5%) [1]. The low gain achieved in the MSP ($<10^3$) and the low photon flux produced in the scintillation region, at normal operation conditions, will result in a low photocathode ageing. Additionally, it will also result in a negligible charge build-up, taking into account that the semiconductive characteristics of the CsI coating are comparable to those of the semiconducting glass substrates used for high-rate MSP applications [3,4].

Comparing to the procedures used in the pioneering work of Ref. [29], where the feasibility of detecting VUV photons with a CsI covered MSP was demonstrated, we further heated the photocathode under vacuum after its exposure to air for photocathode-performance improvement.

Argon-xenon mixtures may combine the advantages of the improved photoelectron collection efficiency achieved in argon-based mixtures with the lower mean energy to produce primary electrons (thus, higher number of primary electrons) and with higher MSP charge gain of xenon-based mixtures. Thus, a GPSC/MSGC hybrid detector filled with argon-xenon mixtures may present improved characteristics when compared with those achieved with pure-argon and/or pure-xenon. Future work to improve detector energy resolution and signal-to-noise ratio will include the study of the performance of argonxenon hybrid detectors as a function of xenon concentration.

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